Intel - EP4CE30F29C6N Datasheet





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Details

Product Status	Active
Number of LABs/CLBs	1803
Number of Logic Elements/Cells	28848
Total RAM Bits	608256
Number of I/O	532
Number of Gates	-
Voltage - Supply	1.15V ~ 1.25V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	780-BGA
Supplier Device Package	780-FBGA (29x29)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep4ce30f29c6n

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Figure 5–23 shows a functional simulation of the PLL reconfiguration feature.

Figure 5-23. PLL Reconfiguration Scan Chain

When reconfiguring the counter clock frequency, the corresponding counter phase shift settings cannot be reconfigured using the same interface. You can reconfigure phase shifts in real time using the dynamic phase shift reconfiguration interface. If you reconfigure the counter frequency, but wish to keep the same non-zero phase shift setting (for example, 90°) on the clock output, you must reconfigure the phase shift after reconfiguring the counter clock frequency.

Post-Scale Counters (C0 to C4)

You can configure multiply or divide values and duty cycle of post-scale counters in real time. Each counter has an 8-bit high time setting and an 8-bit low time setting. The duty cycle is the ratio of output high or low time to the total cycle time, that is the sum of the two. Additionally, these counters have two control bits, rbypass, for bypassing the counter, and rselodd, to select the output clock duty cycle.

When the rbypass bit is set to 1, it bypasses the counter, resulting in a divide by one. When this bit is set to 0, the PLL computes the effective division of the VCO output frequency based on the high and low time counters. For example, if the post-scale divide factor is 10, the high and low count values are set to 5 and 5, to achieve a 50–50% duty cycle. The PLL implements this duty cycle by transitioning the output clock from high-to-low on the rising edge of the VCO output clock. However, a 4 and 6 setting for the high and low count values, respectively, would produce an output clock with a 40–60% duty cycle.

The rselodd bit indicates an odd divide factor for the VCO output frequency with a 50% duty cycle. For example, if the post-scale divide factor is three, the high and low time count values are 2 and 1, respectively, to achieve this division. This implies a 67%–33% duty cycle. If you need a 50%–50% duty cycle, you must set the rselodd control bit to 1 to achieve this duty cycle despite an odd division factor. The PLL implements this duty cycle by transitioning the output clock from high-to-low on a falling edge of the VCO output clock. When you set rselodd = 1, subtract 0.5 cycles from the high time and add 0.5 cycles to the low time.

For example:

■ High time count = 2 cycles

- Low time count = 1 cycle
- rselodd = 1 effectively equals:
 - High time count = 1.5 cycles
 - Low time count = 1.5 cycles
 - Duty cycle = (1.5/3)% high time count and (1.5/3)% low time count

Scan Chain Description

Cyclone IV PLLs have a 144-bit scan chain.

Table 5–7 lists the number of bits for each component of the PLL.

Table 5–7.	Cyclone	IV PLL	Reprogramming Bits
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Plack Nomo	Number of Bits										
DIUCK Name	Counter	Other	Total								
C4 (1)	16	2 (2)	18								
C3	16	2 (2)	18								
C2	16	2 (2)	18								
C1	16	2 (2)	18								
CO	16	2 (2)	18								
М	16	2 (2)	18								
Ν	16	2 (2)	18								
Charge Pump	9	0	9								
Loop Filter ⁽³⁾	9	0	9								
Total number of bits:			144								

Notes to Table 5-7:

(1) LSB bit for C4 low-count value is the first bit shifted into the scan chain.

- (2) These two control bits include <code>rbypass</code>, for bypassing the counter, and <code>rselodd</code>, to select the output clock duty cycle.
- (3) MSB bit for loop filter is the last bit shifted into the scan chain.

Figure 5–24 shows the scan chain order of the PLL components.

Figure 5–24. PLL Component Scan Chain Order



Figure 6–4 shows the single-ended I/O standards for OCT without calibration. The R_S shown is the intrinsic transistor impedance.





All I/O banks and I/O pins support impedance matching and series termination. Dedicated configuration pins and JTAG pins do not support impedance matching or series termination.

 R_S OCT is supported on any I/O bank. V_{CCIO} and V_{REF} must be compatible for all I/O pins to enable R_S OCT in a given I/O bank. I/O standards that support different R_S values can reside in the same I/O bank as long as their V_{CCIO} and V_{REF} do not conflict.

Impedance matching is implemented using the capabilities of the output driver and is subject to a certain degree of variation, depending on the process, voltage, and temperature.



For more information about tolerance specification, refer to the *Cyclone IV Device Datasheet* chapter.

I/O Standards

Cyclone IV devices support multiple single-ended and differential I/O standards. Cyclone IV devices support 3.3-, 3.0-, 2.5-, 1.8-, 1.5-, and 1.2-V I/O standards.

Table 6–3 summarizes I/O standards supported by Cyclone IV devices and which I/O pins support them.

Table 6-3.	. Cyclone IV Devices Supported I/O Standards a	nd Constraints	(Part 1 of 3)
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			V _{CCIO} Leve	el (in V)	C	olumn I/O P	Row I/O Pins ⁽¹⁾		
I/O Standard	Туре	Standard Support	Input	Output	CLK, DQS	PLL_OUT	User I/O Pins	CLK, DQS	User I/O Pins
3.3-V LVTTL, 3.3-V LVCMOS <i>(2)</i>	Single-ended	JESD8-B	3.3/3.0/2.5 <i>(3)</i>	3.3	~	~	\checkmark	~	~
3.0-V LVTTL, 3.0-V LVCMOS <i>(2)</i>	Single-ended	JESD8-B	3.3/3.0/2.5 <i>(3)</i>	3.0	~	~	~	~	~

]	Chapter 6: I/O Banks
	I/O Fea
	ntures ir
	ı Cyclon
	e IV De

ices

Table 6-4. Number of VREF Pins Per I/O Bank for Cyclone IV E Devices (Part 2 of 2)

Device		EP4CE6			EP4CE10				- 107 G	E146E13				EP4CE22			EP4CE30				Er46E4U			EP4CE55			EP4CE75		EDAFE11E	Er4veiij
l/O Bank (1)	144-EQPF	256-UBGA	256-FBGA	144-EQPF	256-UBGA	256-FBGA	144-EQPF	164-MBGA	256-MBGA	256-UBGA	256-FBGA	484-FBGA	144-EQPF	256-UBGA	256-FBGA	324-FBGA	484-FBGA	780-FBGA	324-FBGA	484-UBGA	484-FBGA	780-FBGA	484-UBGA	484-FBGA	780-FBGA	484-UBGA	484-FBGA	780-FBGA	484-FBGA	780-FBGA
8	1	1	1	1	1	1	2	2	2	2	2	2	1	1	1	4	4	4	4	4	4	4	2	2	2	3	3	3	3	3

Note to Table 6-4:

(1) User I/O pins are used as inputs or outputs; clock input pins are used as inputs only; clock output pins are used as output only.

lable 6–5.	Number	of VREF	Pins Per	I/O Bank fo	or Cyclone I	V GX Devices
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Device	4CGX15	4CG	i X22		4CGX30		4CGX50		4CGX75			4CGX110		4CGX150			
i/O Bank (1)	169-FBGA	169-FBGA	324-FBGA	169-FBGA	324-FBGA	484-FBGA	484-FBGA	672-FBGA	484-FBGA	672-FBGA	484-FBGA	672-FBGA	896-FBGA	484-FBGA	672-FBGA	896-FBGA	
3	1	-	1		1	3	3 3		3		3			3			
4	1	-	1		1	3		3 3		3		3			3		
5	1	-	1		1	3	:	3	3		3			3			
6	1	-	1		1	3	3		3	3	3			3			
7	1		1		1	3	3		3			3		3		3	
8 (2)	1		1		1	3	:	3	3	3		3			3		

Notes to Table 6-5:

(1) User I/O pins are used as inputs or outputs; clock input pins are used as inputs only; clock output pins are used as output only.

(2) Bank 9 does not have VREF pin. If input pins with VREF I/O standards are used in bank 9 during user mode, it shares the VREF pin in bank 8.

Each Cyclone IV I/O bank has its own VCCIO pins. Each I/O bank can support only one V_{CCIO} setting from among 1.2, 1.5, 1.8, 2.5, 3.0, or 3.3 V. Any number of supported single-ended or differential standards can be simultaneously supported in a single I/O bank, as long as they use the same V_{CCIO} levels for input and output pins.

Figure 7–3 shows the location and numbering of the DQS, DQ, or CQ# pins in I/O banks of the Cyclone IV GX device in the 324-pin FBGA package only.



Figure 7-3. DQS, CQ, or CQ# Pins for Cyclone IV GX Devices in the 324-Pin FBGA Package

Figure 7–4 shows the location and numbering of the DQS, DQ, or CQ# pins in I/O banks of the Cyclone IV GX device in the 169-pin FBGA package.



Figure 7-4. DQS, CQ, or CQ# Pins for Cyclone IV GX Devices in the 169-Pin FBGA Package



Figure 8–26. JTAG Configuration of Multiple Devices Using a Download Cable (1.2, 1.5, and 1.8-V V_{CCIO} Powering the JTAG Pins)

Notes to Figure 8-26:

- (1) Connect these pull-up resistors to the V_{CCI0} supply of the bank in which the pin resides.
- (2) Connect the nCONFIG and MSEL pins to support a non-JTAG configuration scheme. If you only use a JTAG configuration, connect the nCONFIG pin to logic-high and the MSEL pins to GND. In addition, pull DCLK and DATA[0] to either high or low, whichever is convenient on your board.
- (3) In the USB-Blaster and ByteBlaster II cable, this pin is connected to nCE when it is used for AS programming, otherwise it is a no connect.
- (4) You must connect the nCE pin to GND or driven low for successful JTAG configuration.
- (5) Power up the V_{CC} of the ByteBlaster II or USB-Blaster cable with supply from V_{CCI0}. The ByteBlaster II and USB-Blaster cables do not support a target supply voltage of 1.2 V. For the target supply voltage value, refer to the ByteBlaster II Download Cable User Guide and the USB-Blaster Download Cable User Guide.
- (6) Resistor value can vary from 1 k Ω to 10 k Ω .
 - IF a non-Cyclone IV device is cascaded in the JTAG-chain, TDO of the non-Cyclone IV device driving into TDI of the Cyclone IV device must fit the maximum overshoot outlined in Equation 8–1 on page 8–5.

The CONF_DONE and nSTATUS signals are shared in multi-device AS, AP, PS, and FPP configuration chains to ensure that the devices enter user mode at the same time after configuration is complete. When the CONF_DONE and nSTATUS signals are shared among all the devices, you must configure every device when JTAG configuration is performed.

If you only use JTAG configuration, Altera recommends that you connect the circuitry as shown in Figure 8–25 or Figure 8–26, in which each of the CONF_DONE and nSTATUS signals are isolated so that each device can enter user mode individually.

After the first device completes configuration in a multi-device configuration chain, its nCEO pin drives low to activate the nCE pin of the second device, which prompts the second device to begin configuration. Therefore, if these devices are also in a JTAG chain, ensure that the nCE pins are connected to GND during JTAG configuration or that the devices are JTAG configured in the same order as the configuration chain. As long as the devices are JTAG configured in the same order as the multi-device configuration chain, the nCEO of the previous device drives the nCE pin of the next device low when it has successfully been JTAG configured. You can place other Altera devices that have JTAG support in the same JTAG chain for device programming and configuration.

- The **.rbf** used by the JRunner software driver cannot be a compressed **.rbf** because the JRunner software driver uses JTAG-based configuration. During JTAG-based configuration, the real-time decompression feature is not available.
- **C** For more information about the JRunner software driver, refer to *AN* 414: JRunner *Software Driver: An Embedded Solution for PLD JTAG Configuration* and the source files on the Altera website at (www.altera.com).

Combining JTAG and AS Configuration Schemes

You can combine the AS configuration scheme with the JTAG-based configuration (Figure 8–28). This setup uses two 10-pin download cable headers on the board. One download cable is used in JTAG mode to configure the Cyclone IV device directly through the JTAG interface. The other download cable is used in AS mode to program the serial configuration device in-system through the AS programming interface. If you try configuring the device using both schemes simultaneously, JTAG configuration takes precedence and AS configuration terminates.

Pin Name	User Mode	Configuration Scheme	Pin Type	Description
CONF_DONE	N/A	All	Bidirectional open-drain	 Status output—the target Cyclone IV device drives the CONF_DONE pin low before and during configuration. After all the configuration data is received without error and the initialization cycle starts, the target device releases CONF_DONE. Status input—after all the data is received and CONF_DONE goes high, the target device initializes and enters user mode. The CONF_DONE pin must have an
				external 10-kΩ pull-up resistor in order for the device to initialize. Driving CONF_DONE low after configuration and initialization does not affect the configured device. Do not connect hus
				holds or ADC to CONF_DONE pin.
nCE	N/A	All	Input	Active-low chip enable. The nCE pin activates the Cyclone IV device with a low signal to allow configuration. You must hold nCE pin low during configuration, initialization, and user-mode. In a single-device configuration, you must tie the nCE pin low. In a multi-device configuration, nCE of the first device is tied low while its nCEO pin is connected to nCE of the next device in the chain. You must hold the nCE pin low for successful JTAG programming of the device.
	N/A if option is on.		Qutout	Output that drives low when configuration is complete. In a single-device configuration, you can leave this pin floating or use it as a user I/O pin after configuration. In a multi-device configuration, this pin feeds the nCE pin of the next device. The $nCEO$ of the last device in the chain is left floating or used as a user I/O pin after configuration.
nCEO	I/O if option is off.	All	open-drain	If you use the nCEO pin to feed the nCE pin of the next device, use an external 10-k Ω pull-up resistor to pull the nCEO pin high to the V _{CCIO} voltage of its I/O bank to help the internal weak pull-up resistor.
				If you use the nCEO pin as a user I/O pin after configuration, set the state of the pin on the Dual-Purpose Pin settings.
nCSO, FLASH_nCE (1)				Output control signal from the Cyclone IV device to the serial configuration device in AS mode that enables the configuration device. This pin functions as nCSO in AS mode and FLASH_nCE in AP mode.
	I/O	AS, AP <i>(2)</i>	Output	Output control signal from the Cyclone IV device to the parallel flash in AP mode that enables the flash. Connects to the $CE\#$ pin on the Micron P30 or P33 flash. ⁽²⁾
				This pin has an internal pull-up resistor that is always active.

Table 8-20	. Dedicated	Configuration	Pins on th	ne Cyclone	IV Device	(Part 2 of 4)
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Table 8–21 lists the optional configuration pins. If you do not enable these optional configuration pins in the Quartus II software, they are available as general-purpose user I/O pins. Therefore, during configuration, these pins function as user I/O pins and are tri-stated with weak pull-up resistors.

Pin Name	User Mode	Pin Type	Description
	N/A if option is on		Optional user-supplied clock input synchronizes the initialization of one or more devices. This pin is enabled by turning on the Enable user-supplied start-up clock (CLKUSR) option in the Quartus II software.
CLKUSR	I/O if option is off.	Input	In AS configuration for Cyclone IV GX devices, you can use this pin as an external clock source to generate the DCLK by changing the clock source option in the Quartus II software in the Configuration tab of the Device and Pin Options dialog box.
INIT_DONE	N/A if option is on. I/O if option is off.	Output open-drain	Status pin is used to indicate when the device has initialized and is in user-mode. When nCONFIG is low, the INIT_DONE pin is tri-stated and pulled high due to an external 10-k Ω pull-up resistor during the beginning of configuration. After the option bit to enable INIT_DONE is programmed into the device (during the first frame of configuration data), the INIT_DONE pin goes low. When initialization is complete, the INIT_DONE pin is released and pulled high and the device enters user mode. Thus, the monitoring circuitry must be able to detect a low-to- high transition. This pin is enabled by turning on the Enable INIT_DONE output option in the Quartus II software.
			The functionality of this pin changes if the Enable OCT_DONE option is enabled in the Quartus II software. This option controls whether the INIT_DONE signal is gated by the OCT_DONE signal, which indicates the power-up on-chip termination (OCT) calibration is complete. If this option is turned off, the INIT_DONE signal is not gated by the OCT_DONE signal.
DEV_OE	N/A if option is on. I/O if option is off.	Input	Optional pin that allows you to override all tri-states on the device. When this pin is driven low, all I/O pins are tri-stated; when this pin is driven high, all I/O pins behave as programmed. This pin is enabled by turning on the Enable device-wide output enable (DEV_OE) option in the Quartus II software.
DEV_CLRn	N/A if option is on. I/O if option is off.	Input	Optional pin that allows you to override all clears on all device registers. When this pin is driven low, all registers are cleared; when this pin is driven high, all registers behave as programmed. You can enable this pin by turning on the Enable device-wide reset (DEV_CLRn) option in the Quartus II software.

Table 8–21. Optional Configuration Pins

Table 9–6 lists the estimated time for each CRC calculation with minimum and maximum clock frequencies for Cyclone IV devices.

Table	9–6.	CRC	Calculation	Time
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Dev	vice	Minimum Time (ms) ⁽¹⁾	Maximum Time (s) ⁽²⁾
	EP4CE6 (3)	5	2.29
	EP4CE10 (3)	5	2.29
	EP4CE15 (3)	7	3.17
	EP4CE22 (3)	9	4.51
Cyclone IV E	EP4CE30 (3)	15	7.48
	EP4CE40 (3)	15	7.48
	EP4CE55 (3)	23	11.77
	EP4CE75 (3)	31	15.81
	EP4CE115 (3)	45	22.67
	EP4CGX15	6	2.93
	EP4CGX22	12	5.95
		12	5.95
Cuelone IV CV		34 (4)	17.34 <i>(4)</i>
	EP4CGX50	34	17.34
	EP4CGX75	34	17.34
	EP4CGX110	62	31.27
	EP4CGX150	62	31.27

Notes to Table 9-6:

(1) The minimum time corresponds to the maximum error detection clock frequency and may vary with different processes, voltages, and temperatures (PVT).

(2) The maximum time corresponds to the minimum error detection clock frequency and may vary with different PVT.

(3) Only applicable for device with 1.2-V core voltage

(4) Only applicable for the F484 device package.

Software Support

Enabling the CRC error detection feature in the Quartus II software generates the CRC_ERROR output to the optional dual purpose CRC_ERROR pin.

To enable the error detection feature using CRC, perform the following steps:

- 1. Open the Quartus II software and load a project using Cyclone IV devices.
- 2. On the Assignments menu, click Settings. The Settings dialog box appears.
- 3. In the Category list, select **Device**. The **Device** page appears.
- 4. Click **Device and Pin Options**. The **Device and Pin Options** dialog box appears as shown in Figure 9–2.
- 5. In the **Device and Pin Options** dialog box, click the **Error Detection CRC** tab.
- 6. Turn on Enable error detection CRC.
- 7. In the **Divide error check frequency by** box, enter a valid divisor as documented in Table 9–5 on page 9–5.

Receiver Channel Datapath

The following sections describe the Cyclone IV GX receiver channel datapath architecture as shown in Figure 1–3 on page 1–4:

- "Receiver Input Buffer" on page 1–11
- "Clock Data Recovery" on page 1–15
- "Deserializer" on page 1–16
- "Word Aligner" on page 1–17
- "Deskew FIFO" on page 1–22
- "Rate Match FIFO" on page 1–23
- "8B/10B Decoder" on page 1–23
- "Byte Deserializer" on page 1–24
- "Byte Ordering" on page 1–24
- "RX Phase Compensation FIFO" on page 1–25

Receiver Input Buffer

Table 1–2 lists the electrical features supported by the Cyclone IV GX receiver input buffer.

Table 1-2.	Electrical	Features	Supported	by the	Receiver	Input Buffer
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I/O Standard	Programmable Common Mode Voltage (V)	Coupling		
1.4-V PCML	0.82	AC, DC		
1.5-V PCML	0.82	AC, DC		
2.5-V PCML	0.82	AC		
LVPECL	0.82	AC		
LVDS	0.82	AC, DC (1)		

Note to Table 1–2:

(1) DC coupling is supported for LVDS with lower on-chip common mode voltage of 0.82 V.

The high-speed serial link can be AC- or DC-coupled, depending on the serial protocol implementation. In an AC-coupled link, the AC-coupling capacitor blocks the transmitter DC common mode voltage as shown in Figure 1–12. Receiver OCT and on-chip biasing circuitry automatically restores the common mode voltage. The biasing circuitry is also enabled by enabling OCT. If you disable the OCT, then you must externally terminate and bias the receiver. AC-coupled links are required for PCIe, GbE, Serial RapidIO, SDI, XAUI, SATA, V-by-One and Display Port protocols.



Figure 1–12. AC-Coupled Link with OCT

The hard IP block supports 1, 2, or 4 initial lane configurations with a maximum payload of 256 bytes at Gen1 frequency. The application interface is 64 bits with a data width of 16 bits per channel running at up to 125 MHz. As a hard macro and a verified block, it uses very few FPGA resources, while significantly reducing design risk and the time required to achieve timing closure. It is compliant with the PCI Express Base Specification 1.1. You do not have to pay a licensing fee to use this module. Configuring the hard IP block requires using the PCI Express Compiler.



For more information about the hard IP block, refer to the *PCI Express Compiler User Guide*.

Figure 1–43 shows the lane placement requirements when implementing PCIe with hard IP block.



Figure 1–43. PCIe with Hard IP Block Lane Placement Requirements ⁽¹⁾

Note to Figure 1-43:

(1) Applicable for PCle ×1, ×2, and ×4 implementations with hard IP blocks only.

PCIe Lane 0

Transceiver Functional Modes

The Cyclone IV GX transceiver supports the functional modes as listed in Table 1–14 for protocol implementation.

Functional Mode	Protocol	Key Feature	Reference
Basic	Proprietary, SATA, V- by-One, Display Port	Low latency PCS, transmitter in electrical idle, signal detect at receiver, wider spread asynchronous SSC	"Basic Mode" on page 1–48
PCI Express (PIPE)	PCIe Gen1 with PIPE Interface	PIPE ports, receiver detect, transmitter in electrical idle, electrical idle inference, signal detect at receiver, fast recovery, protocol-compliant word aligner and rate match FIFO, synchronous SSC	"PCI Express (PIPE) Mode" on page 1–52
GIGE	GbE	Running disparity preservation, protocol-compliant word aligner, recovered clock port for applications such as Synchronous Ethernet	"GIGE Mode" on page 1–59
Serial RapidIO	SRIO	Protocol-compliant word aligner	"Serial RapidIO Mode" on page 1–64
XAUI	XAUI	Deskew FIFO, protocol-compliant word aligner and rate match FIFO	"XAUI Mode" on page 1–67

Table 1–14. Transceiver Functional Modes for Protocol Implementation (Part 1 of 2)

Reverse Parallel Loopback

The reverse parallel loopback option is only available for PIPE mode. In this mode, the received serial data passes through the receiver CDR, deserializer, word aligner, and rate match FIFO before looping back to the transmitter serializer and transmitted out through the TX buffer, as shown in Figure 1–70. The received data is also available to the FPGA fabric. This loopback mode is compliant with version 2.00 of the *PHY Interface for the PCI Express Architecture* specification.

To enable the reverse parallel loopback mode, assert the tx_detectrxloopback port in P0 power state.

Figure 1–70. PIPE Reverse Parallel Loopback Path (1)



Note to Figure 1–70: (1) Grayed-Out Blocks are Not Active in this mode.

Serial Loopback

The serial loopback option is available for all functional modes except PIPE mode. In this mode, the data from the FPGA fabric passes through the transmitter channel and looped back to the receiver channel, bypassing the receiver buffer, as shown in Figure 1–71. The received data is available to the FPGA logic for verification. The receiver input buffer is not active in this mode. With this option, you can check the operation of all enabled PCS and PMA functional blocks in the transmitter and receiver channels.

The transmitter channel sends the data to both the serial output port and the receiver channel. The differential output voltage on the serial ports is based on the selected V_{OD} settings. The data is looped back to the receiver CDR and is retimed through different clock domains. You must provide an alignment pattern for the word aligner to enable the receiver channel to retrieve the byte boundary.

Transmitter Only Channel

This configuration contains only a transmitter channel. If you create a **Transmitter Only** instance in the ALTGX MegaWizard Plug-In Manager, use the same reset sequence shown in Figure 2–3 on page 2–7.

Receiver Only Channel—Receiver CDR in Automatic Lock Mode

This configuration contains only a receiver channel. If you create a **Receiver Only** instance in the ALTGX MegaWizard Plug-In Manager with the receiver CDR in automatic lock mode, use the reset sequence shown in Figure 2–6.

Figure 2–6. Sample Reset Sequence of Receiver Only Channel—Receiver CDR in Automatic Lock Mode



Notes to Figure 2-6:

- (1) For t_{LTD Auto} duration, refer to the *Cyclone IV Device Datasheet* chapter.
- (2) The busy signal is asserted and deasserted only during initial power up when offset cancellation occurs. In subsequent reset sequences, the busy signal is asserted and deasserted only if there is a read or write operation to the ALTGX_RECONFIG megafunction.

As shown in Figure 2–6, perform the following reset procedure for the receiver in CDR automatic lock mode:

- 1. After power up, wait for the busy signal to be deasserted.
- 2. Keep the rx_digitalreset and rx_analogreset signals asserted during this time period.
- 3. After the busy signal is deasserted, wait for another two parallel clock cycles, then deassert the rx analogreset signal.
- 4. Wait for the rx_freqlocked signal to go high.
- 5. When rx_freqlocked goes high (marker 3), from that point onwards, wait for at least t_{LTD_Auto}, then de-assert the rx_digitalreset signal (marker 4). At this point, the receiver is ready to receive data.

Receiver Only Channel—Receiver CDR in Manual Lock Mode

This configuration contains only a receiver channel. If you create a **Receiver Only** instance in the ALTGX MegaWizard Plug-In Manager with receiver CDR in manual lock mode, use the reset sequence shown in Figure 2–7.

Figure 2-7. Sample Reset Sequence of Receiver Only Channel—Receiver CDR in Manual Lock Mode



Notes to Figure 2–7:

- (1) For t_{LTR LTD Manual} duration, refer to the *Cyclone IV Device Datasheet* chapter.
- (2) For $t_{LTD Manual}$ duration, refer to the *Cyclone IV Device Datasheet* chapter.
- (3) The busy signal is asserted and deasserted only during initial power up when offset cancellation occurs. In subsequent reset sequences, the busy signal is asserted and deasserted only if there is a read or write operation to the ALTGX_RECONFIG megafunction.

As shown in Figure 2–7, perform the following reset procedure for the receiver CDR in manual lock mode:

- 1. After power up, wait for the busy signal to be asserted.
- 2. Keep the rx_digitalreset and rx_locktorefclk signals asserted and the rx_locktodata signal deasserted during this time period.
- 3. After deassertion of the busy signal (marker 1), wait for two parallel clock cycles to deassert the rx_analogreset signal (marker 2). After rx_analogreset deassert, rx_pll_locked will assert.
- 4. Wait for at least t_{LTR_LTD_Manual}, then deassert the rx_locktorefclk signal. At the same time, assert the rx_locktodata signal (marker 3).
- 5. Deassert rx_digital reset at least $t_{\rm LTD_Manual}$ (the time between markers 3 and 4) after asserting the rx_locktodata signal. At this point, the receiver is ready to receive data.

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Section I. Device Datasheet

Chapter 1. Cyclone IV Device Datasheet

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Table 1–23 lists the Cyclone IV GX transceiver block AC specifications.

Symbol/	Conditions	C6		C7, 17			C8			Ilnit	
Description	Description		Тур	Max	Min	Тур	Max	Min	Тур	Max	UNIT
PCIe Transmit Jitter Gene	ration ⁽³⁾										
Total jitter at 2.5 Gbps (Gen1)	Compliance pattern	— — 0.25		0.25 0.25		_	_	0.25	UI		
PCIe Receiver Jitter Tole	rance ⁽³⁾										
Total jitter at 2.5 Gbps (Gen1)	Compliance pattern	ance pattern > 0.6		> 0.6		> 0.6		UI			
GIGE Transmit Jitter Gene	eration ⁽⁴⁾										
Deterministic jitter	Pattern – CBPAT	_		0 14			0 14			0 14	111
(peak-to-peak)				0.14			0.14			0.14	01
Total jitter (peak-to-peak)	Pattern = CRPAT	—	—	0.279	-	—	0.279	_	—	0.279	UI
GIGE Receiver Jitter Tole	rance ⁽⁴⁾										
Deterministic jitter tolerance (peak-to-peak)	Pattern = CJPAT	> 0.4		> 0.4		> 0.4		ļ	UI		
Combined deterministic and random jitter tolerance (peak-to-peak)	Pattern = CJPAT	> 0.66		> 0.66		> 0.66		UI			

Table 1–23. Transceiver Block AC Specification for Cyclone IV GX Devices (1), (2)

Notes to Table 1-23:

(1) Dedicated refclk pins were used to drive the input reference clocks.

(2) The jitter numbers specified are valid for the stated conditions only.

(3) The jitter numbers for PIPE are compliant to the PCIe Base Specification 2.0.

(4) The jitter numbers for GIGE are compliant to the IEEE802.3-2002 Specification.

Core Performance Specifications

The following sections describe the clock tree specifications, PLLs, embedded multiplier, memory block, and configuration specifications for Cyclone IV Devices.

Clock Tree Specifications

Table 1–24 lists the clock tree specifications for Cyclone IV devices.

 Table 1–24.
 Clock Tree Performance for Cyclone IV Devices (Part 1 of 2)

Device	Performance									
Device	C6	C7	C8	C8L ⁽¹⁾	C9L ⁽¹⁾	17	18L ⁽¹⁾	A7	Unit	
EP4CE6	500	437.5	402	362	265	437.5	362	402	MHz	
EP4CE10	500	437.5	402	362	265	437.5	362	402	MHz	
EP4CE15	500	437.5	402	362	265	437.5	362	402	MHz	
EP4CE22	500	437.5	402	362	265	437.5	362	402	MHz	
EP4CE30	500	437.5	402	362	265	437.5	362	402	MHz	
EP4CE40	500	437.5	402	362	265	437.5	362	402	MHz	

Table 1–29 lists the active configuration mode specifications for Cyclone IV devices.

Programming Mode	DCLK Range	Typical DCLK	Unit
Active Parallel (AP) (1)	20 to 40	33	MHz
Active Serial (AS)	20 to 40	33	MHz

Table 1–29. Active Configuration Mode Specifications for Cyclone IV Devices

Note to Table 1-29:

(1) AP configuration mode is only supported for Cyclone IV E devices.

Table 1-30 lists the JTAG timing parameters and values for Cyclone IV devices.

Table 1–30. JTAG Timing Parameters for Cyclone IV Devices (1)

Symbol	Parameter	Min	Max	Unit
t _{JCP}	TCK clock period	40		ns
t _{JCH}	TCK clock high time	19		ns
t _{JCL}	TCK clock low time	19	_	ns
t _{JPSU_TDI}	JTAG port setup time for TDI	1	_	ns
t _{JPSU_TMS}	JTAG port setup time for TMS	3	_	ns
t _{JPH}	JTAG port hold time	10	_	ns
t _{JPC0}	JTAG port clock to output ^{(2), (3)}	—	15	ns
t _{JPZX}	JTAG port high impedance to valid output ^{(2), (3)}	—	15	ns
t _{JPXZ}	JTAG port valid output to high impedance ^{(2), (3)}	—	15	ns
t _{JSSU}	Capture register setup time	5		ns
t _{JSH}	Capture register hold time	10	_	ns
t _{JSC0}	Update register clock to output	—	25	ns
t _{JSZX}	Update register high impedance to valid output	_	25	ns
t _{JSXZ}	Update register valid output to high impedance		25	ns

Notes to Table 1-30:

(1) For more information about JTAG waveforms, refer to "JTAG Waveform" in "Glossary" on page 1-37.

- (2) The specification is shown for 3.3-, 3.0-, and 2.5-V LVTTL/LVCMOS operation of JTAG pins. For 1.8-V LVTTL/LVCMOS and 1.5-V LVCMOS, the output time specification is 16 ns.
- (3) For EP4CGX22, EP4CGX30 (F324 and smaller package), EP4CGX110, and EP4CGX150 devices, the output time specification for 3.3-, 3.0-, and 2.5-V LVTTL/LVCMOS operation of JTAG pins is 16 ns. For 1.8-V LVTTL/LVCMOS and 1.5-V LVCMOS, the output time specification is 18 ns.

Periphery Performance

This section describes periphery performance, including high-speed I/O and external memory interface.

I/O performance supports several system interfaces, such as the high-speed I/O interface, external memory interface, and the PCI/PCI-X bus interface. I/Os using the SSTL-18 Class I termination standard can achieve up to the stated DDR2 SDRAM interfacing speeds. I/Os using general-purpose I/O standards such as 3.3-, 3.0-, 2.5-, 1.8-, or 1.5-LVTTL/LVCMOS are capable of a typical 200 MHz interfacing frequency with a 10 pF load.